



PT-3800A

Plating Thickness Analyzer



EPCC / PRODUCTS / APPLICATION / SOFTWARE / ACCESSORIES / CONSUMABLES / SERVICES

Analytical Technologies Limited

An ISO 9001 Certified Company

www.analyticalgroup.net



Plating thickness measurement Element categories and contents analysis

PT-3800A is specially designed for rapid and non-destructive detection of plating thickness, element categories and contents. The Characteristics are summarized as below:

- 1. Top lightenting
- 2. Up-and-down platform
- 3. High-accuracy movable platform
- 4. Small-apeture collimator
- 5. High-resolution detector
- 6. Visual operation
- 7. Auto height positioning
- 8. Auto spot search
- 9. Mouse positions the test point
- 10. Excellent ray shielding
- 11. Super large chamber design
- 12. Safe protection of test interface



- ◆ Analyzable minimum thickness down to 0.01 µm
- ◆ Collimator is 0.2mm
- ◆ Electronic height sensor
- ◆ High stability copper X-ray tube with micro facula
- ◆ High-accuracy movable sample platform





>> Performance and characteristics

- Measurement of samples with different thicknesses and irregular shapes
- Φ 0.2 micro collimator can test the point
- High-accuracy movable platform can precisely locate the test point with repeated accuracy less than 0.005mm
- · Height positioning laser can auto locate the height
- Positioning laser can precisely locate the facula to ensure the test point aligns to it
- The mouse can control the movable platform; the mouse clicking position is the test point
- High-resolution detector can improve the analysis accuracy
- Excellent ray shielding
- The test interface is protected by high sensitivity sensor



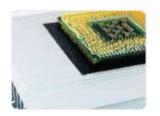
>> Application Fields

Measurement of plating thickness, element compositon of plating and solutions.

Measurement of gold, platinum, silver, other precious metals and verious jewelries composition. Precious metal and ornament processing industries; banks, ornament sale and detection institutes; electroplating industries.









Configurations

- Open sample chamber
- Double-laser positioning system
- Lead glass shield cap
- SDD detector
- Electronic circuit for signal detection
- High and low voltage power supply
- X-rey tube
- Height sensor
- Sensor protection
- Computer and ink jet printer
- 3-D movement is realized by using 2-D movable platform and up-and-down movement of detector and X-ray tube..

>> Specifications:

Measurable elements:	Na~U
Simultaneously analysis ability:	maximum 24 elements & 5 plating layers
Temperature control range:	4°C ~ 450°C above room temperature
Excellent repeatability:	0.1%
Long-time working stacility:	0.1%
Ambient temperature:	15°C - 30°C
Power supply:	AC 220V ±5V, AC purified stabilized power is suggested
Dimension:	576(W)x495(D)x545(H)
Weight:	90kg
Analyzable detection limit of element contentreaches 2ppm	
Analyzable minimum layer is 0.01µm	
Analyzable maximum thickness is within 50µm(depend on different matrix)	
Arbitrary optional analysis and identification models	
Independent matrix effect correction models	
Multi-variable non-liner regresssion procedure	

Regulatory compliances



Corporate Social Responsibility

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- 2. Improving quality of life by offering YOGA Training courses, Work shops/Seminars etc.
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